

**Search Notes**

Application/Control No.

10/757,187

Examiner

David E. Martinez

Applicant(s)/Patent under  
Reexamination

KRAVEC ET AL.

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	1	1/31/2007	DM
382	181, 209	1/31/2007	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent,		1/31/2007	DM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East see attached	1/31/2007	DM
710/1,14,20-21 381/408 382/129,181,209,217-219,229 396/14,15 704/221-223 706/48 707/6 340/995.22 with keywords+text search	1/31/2007	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	1/31/2007	DM
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